



松 明
CNASL1225

partner

FCC PART 15 SUBPART B TEST REPORT

FCC PART 15B

Report Reference No.....: **WE09030005**

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Approved by

(position+printed name+signature)..: Manager Jimmy Li

Date of issue.....: Mar 30, 2009

Testing Laboratory Name: **Shenzhen Huatongwei International Inspection Co., Ltd**

Address.....: Keji Nan No.12 Road, Hi-tech Park, Shenzhen, China

Applicant's name.....: **ASOKA USA CORPORATION**

Address.....: 2344-A Walsh Avenue, Santa Clara City, CA 95051

Test specification:

Standard: **FCC Part 15B- Unintentional Radiators**

TRF Originator.....: Shenzhen Huatongwei International Inspection CO., Ltd

Master TRF.....: Dated 2006-06

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Test item description : PlugLink AV 9660

Trade Mark: /

Model/Type reference.....: PL9660-ETH

Listed Models:

Result.....: **Positive**

TEST REPORT

Test Report No. :	WE09010005	Mar 30, 2009
		Date of issue

Equipment under Test : PlugLink AV 9660

Model /Type : PL9660-ETH

Listed Models :

Applicant : ASOKA USA CORPORATION

Address : 2344-A Walsh Avenue, Santa Clara City, CA 95051

Test Result according to the standards on page 4:	Positive
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The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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1. TEST STANDARDS

The tests were performed according to following standards:

[FCC Rules Part 15 Subpart B - Unintentional Radiators](#)

2. SUMMARY

2.1. General Remarks

Date of receipt of test sample : Mar 26, 2009

Testing commenced on : Mar 27, 2009

Testing concluded on : Mar 30, 2009

2.2. Equipment Under Test

Power supply system utilised

Power supply voltage : ● 120V / 60 Hz ○ 115V / 60Hz
○ 12 V DC ○ 24 V DC
○ Other (specified in blank below)

/

2.3. Short description of the Equipment under Test (EUT)

PlugLink AV 9660
For more details, refer to the user's manual of the EUT.

Serial number: Prototype

2.4. EUT operation mode

The EUT has been tested under typical operating condition.

2.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

- - supplied by the manufacturer
- - supplied by the lab
- Power Cable Length (m) : /
Shield : /
Detachable : /
- Multimeter Manufacturer : /
Model No. : /

2.6. Related Submittal(s) / Grant (s)

This submittal(s) (test report) is intended for FCC ID: **T37PL9660-ETH** filing to comply with the FCC Part 15, Subpart B Rules.

2.7. Modifications

No modifications were implemented to meet testing criteria.

3. TEST ENVIRONMENT

3.1. Address of the test laboratory

Shenzhen Huatongwei International Inspection Co., Ltd
Keji Nan No.12 Road, Hi-tech Park, Shenzhen, China
Phone: 86-755-26715686 Fax: 86-755-26748089

The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 (2003) and CISPR Publication 22.

3.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories, Date of Registration: August 02, 2007. Valid time is until March 04, 2009.

A2LA-Lab Cert. No. 2243.01

Shenzhen Huatongwei International Inspection Co., Ltd, EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing. Valid time is from Aug 24, 2005 to Sept 30, 2009.

FCC-Registration No.: 662850

Shenzhen Huatongwei International Inspection Co., Ltd, EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 662850, Renewal date September, 2009.

IC-Registration No.: 5377

The 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 5377 on November 28th, 2005.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd, EMC Laboratory can also perform testing for the Australian C-Tick mark as a result of our A2LA accreditation.

NEMKO-Aut. No.: ELA125

Shenzhen Huatongwei International Inspection Co., Ltd has been assessed the quality assurance system, the testing facilities, qualifications and testing practices of the relevant parts of the organization. The quality assurance system of the Laboratory has been validated against ISO/IEC 17025:2005 or equivalent. The laboratory also fulfils the conditions described in Nemko Document NLA-10, the Authorization is valid through April 25, 2009.

VCCI

The 3m Semi-anechoic chamber (12.2m×7.95m×6.7m) and Shielded Room (8m×4m×3m) of Shenzhen Huatongwei International Inspection Co., Ltd has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-2484. Date of Registration: December 20, 2006. Valid time is until December 19, 2009.

Main Ports Conducted Interference Measurement of Shenzhen Huatongwei International Inspection Co., Ltd has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: C-2726. Date of Registration: December 20, 2006. Valid time is until December 19, 2009.

IECEE CB

Shenzhen Huatongwei International Inspection Co Ltd has been assessed and determined to fully comply with the requirements of ISO/IEC 17025: 2005-05, The Basic Rules, IECEE 01: 2006-10 and Rules of Procedure IECEE 02: 2006-10, and the relevant IECEE CB-Scheme Operational Documents. It is therefore entitled to operate as a CB Testing Laboratory under the responsibility of Nemko A/S. This certificate remains valid until May 25th 2009 at which time it will be reissued by the IECEE Executive Secretary upon successful completion of the normally scheduled 3-year Reassessment Program administered by the IECEE CB Scheme.

DNV

Shenzhen Huatongwei International Inspection Co Ltd has been found to comply with the requirements of DNV towards subcontractor of EMC and safety testing services in conjunction with the EMC and Low voltage Directives and in the voluntary field. The acceptance is based on a formal quality Audit and follow-ups according to relevant parts of ISO/IEC Guide 17025(2005), in accordance with the requirements of the DNV Laboratory Quality Manual towards subcontractors. Valid time is until 09 July, 2010.

3.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature: 15-35 ° C
 Humidity: 30-60 %
 Atmospheric pressure: 950-1050mbar

3.4. Configuration of Tested System

Fig. 2-1 Configuration of Tested System

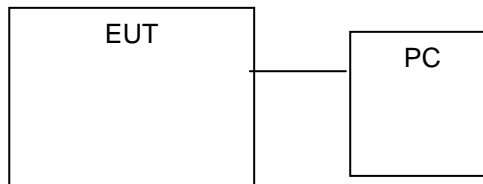


Table 2-1 Equipment Used in Tested System

No.	Product	Manufacturer	Model No.	Serial No.	
	Notebook PC	HP	Pavilion ze2000	CNF614170YQ	

3.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 „Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen Huatongwei laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.22dB	(1)
Radiated Emission	1~12.75GHz	4.35dB	(1)
Conducted Disturbance	0.15~30MHz	3.29dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6. Equipments Used during the Test

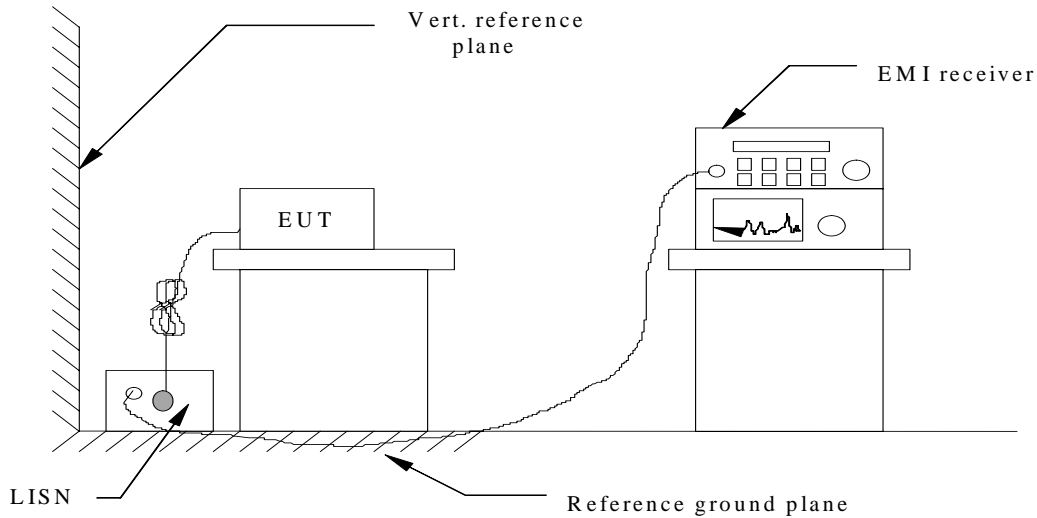
AC Power Conducted Emission					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESCI	100106	2008/11
2	ARTIFICIAL MAINS	ROHDE & SCHWARZ	ESH2-Z5	100028	2008/11
3	PULSE LIMITER	ROHDE & SCHWARZ	ESHSZ2	100044	2008/11
4	EMI TEST SOFTWARE	ROHDE & SCHWARZ	ES-K1 1.71	N/A	2008/11

Radiated Emissions					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	ULTRA-BROADBAND ANTENNA	ROHDE & SCHWARZ	HL562	100015	2008/11
2	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESI 26	100009	2008/11
3	RF TEST PANEL	ROHDE & SCHWARZ	TS / RSP	335015/ 0017	2008/11
4	TURNTABLE	ETS	2088	2149	2008/11
5	ANTENNA MAST	ETS	2075	2346	2008/11
6	EMI TEST SOFTWARE	ROHDE & SCHWARZ	ESK1	N/A	2008/11

4. TEST CONDITIONS AND RESULTS

4.1. Conducted Emissions Test

TEST CONFIGURATION



TEST PROCEDURE

- 1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.4.
- 2 Support equipment, if needed, was placed as per ANSI C63.4.
- 3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.4.
- 4 The EUT received the AC120V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- 5 All support equipments received AC power from a second LISN, if any.
- 6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.
- 8 During the above scans, the emissions were maximized by cable manipulation.

Conducted Power Line Emission Limit

For unintentional device, according to § 15.107(a) Line Conducted Emission Limits is as following :

Frequency (MHz)	Maximum RF Line Voltage (dBµV)			
	CLASS A		CLASS B	
	Q.P.	Ave.	Q.P.	Ave.
0.15 - 0.50	79	66	66-56*	56-46*
0.50 - 5.00	73	60	56	46
5.00 - 30.0	73	60	60	50

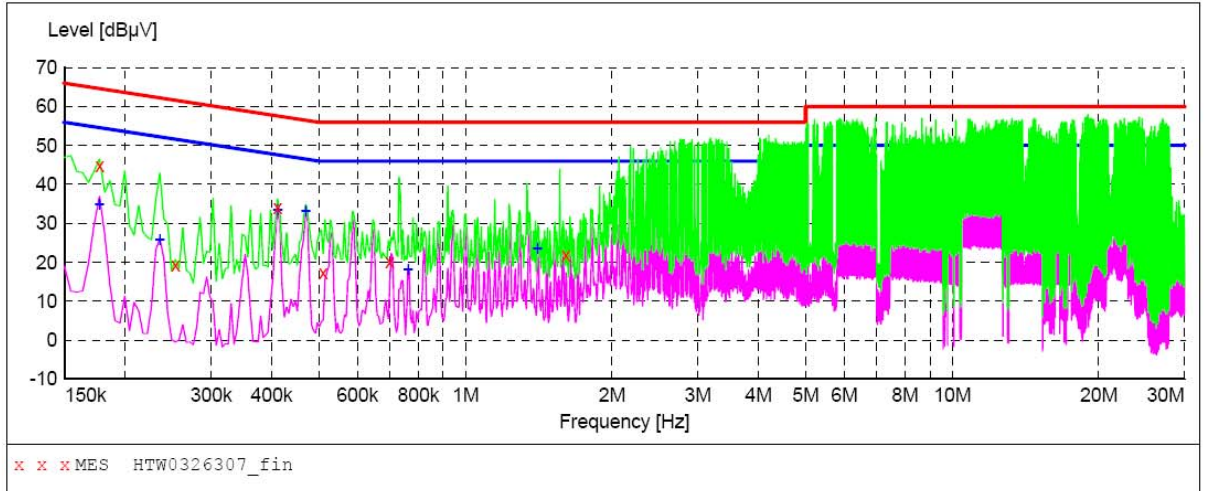
* Decreasing linearly with the logarithm of the frequency

For intentional device, according to §15.207(a) Line Conducted Emission Limit is same as above table.

TEST RESULTS

SCAN TABLE: "Voltage (9K-30M) FIN"

Short Description: 150K-30M Voltage



MEASUREMENT RESULT: "HTW0326307_fin"

3/26/2009 10:13AM

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.177000	44.70	10.2	65	19.9	QP	L1	GND
0.253500	19.40	10.2	62	42.2	QP	L1	GND
0.411000	34.00	10.2	58	23.6	QP	L1	GND
0.510000	17.20	10.2	56	38.8	QP	L1	GND
0.699000	20.20	10.2	56	35.8	QP	L1	GND
1.608000	21.80	10.3	56	34.2	QP	L1	GND

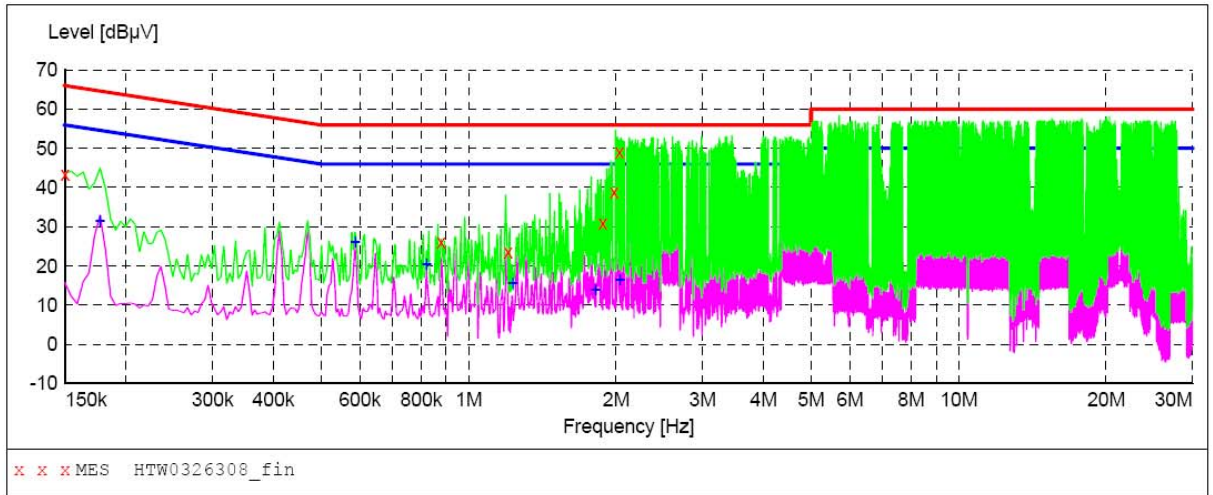
MEASUREMENT RESULT: "HTW0326307_fin2"

3/26/2009 10:13AM

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.177000	34.80	10.2	55	19.8	AV	L1	GND
0.235500	25.70	10.2	52	26.6	AV	L1	GND
0.411000	33.60	10.2	48	14.0	AV	L1	GND
0.469500	33.10	10.2	47	13.4	AV	L1	GND
0.762000	18.30	10.2	46	27.7	AV	L1	GND
1.405500	23.60	10.3	46	22.4	AV	L1	GND

SCAN TABLE: "Voltage (9K-30M) FIN"

Short Description: 150K-30M Voltage



MEASUREMENT RESULT: "HTW0326308_fin"

3/26/2009 10:24AM

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.150000	43.30	10.2	66	22.7	QP	N	GND
0.879000	26.10	10.2	56	29.9	QP	N	GND
1.203000	23.70	10.3	56	32.3	QP	N	GND
1.878000	31.00	10.3	56	25.0	QP	N	GND
1.981500	38.80	10.3	56	17.2	QP	N	GND
2.031000	49.10	10.4	56	6.9	QP	N	GND

MEASUREMENT RESULT: "HTW0326308_fin2"

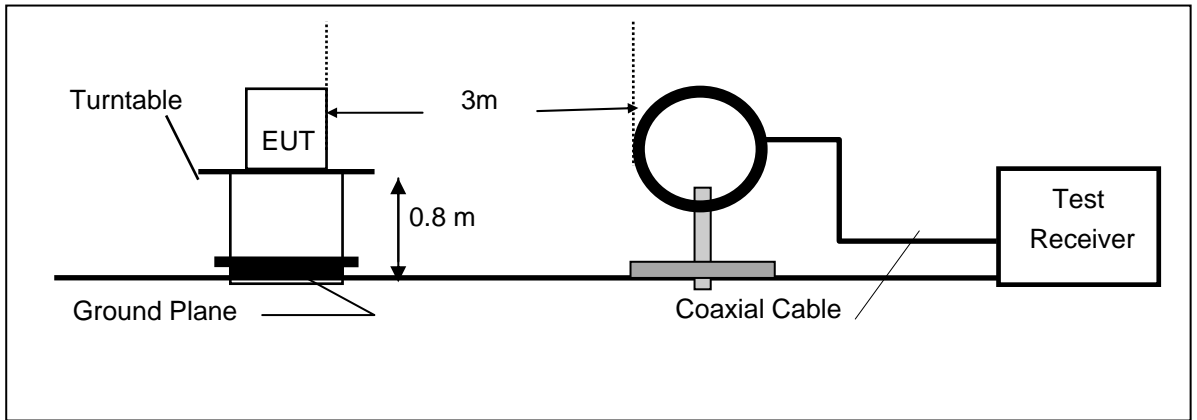
3/26/2009 10:24AM

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.177000	31.60	10.2	55	23.0	AV	N	GND
0.586500	26.00	10.2	46	20.0	AV	N	GND
0.820500	20.40	10.2	46	25.6	AV	N	GND
1.230000	15.60	10.3	46	30.4	AV	N	GND
1.815000	13.90	10.3	46	32.1	AV	N	GND
2.035500	16.40	10.4	46	29.6	AV	N	GND

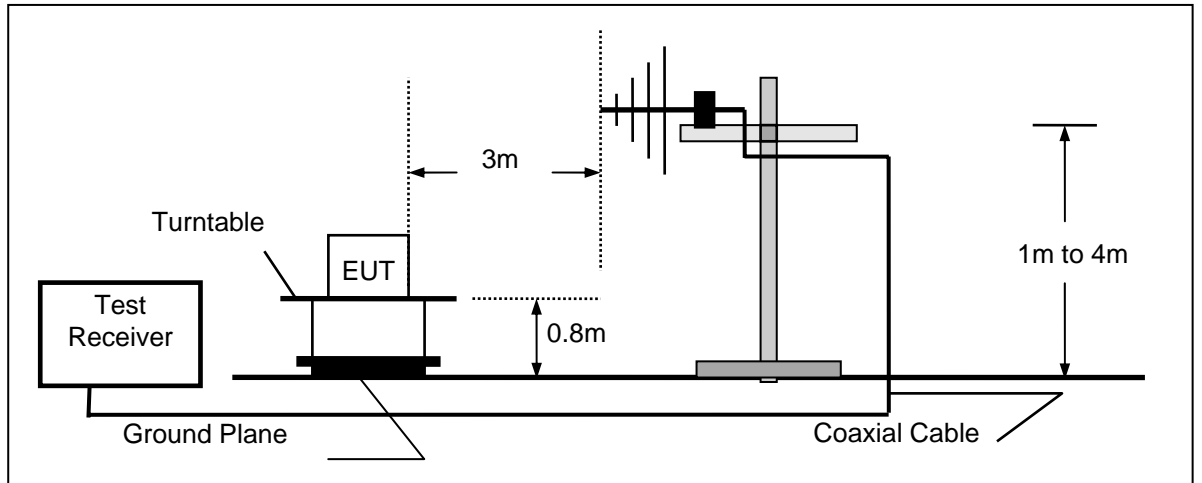
4.2. Radiated Emission Test

TEST CONFIGURATION

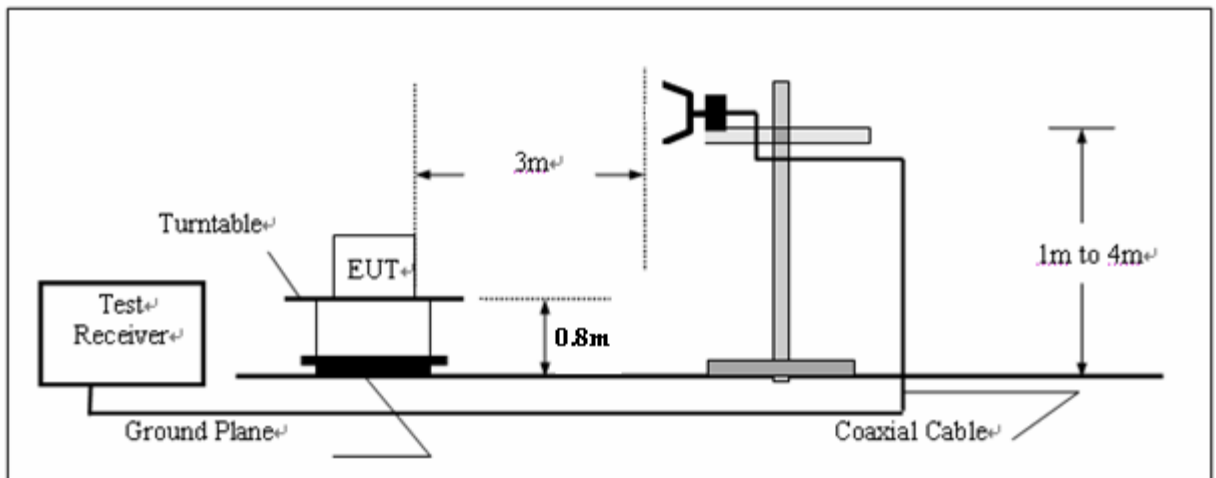
(A) Radiated Emission Test Set-Up, Frequency Below 30MHz



(B) Radiated Emission Test Set-Up, Frequency below 1000MHz



(C) Radiated Emission Test Set-Up, Frequency above 1000MHz



TEST PROCEDURE

- 1 The EUT was placed on a turn table which is 0.8m above ground plane.
- 2 Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0° to 360° to acquire the highest emissions from EUT
3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
4. Repeat above procedures until all frequency measurements have been completed.

Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

$$FS = RA + AF + CL - AG$$

Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	

RADIATION LIMIT

For unintentional device, according to § 15.109(a), except for Class A digital devices, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
30-88	3	40.0	100
88-216	3	43.5	150
216-960	3	46.0	200
Above 960	3	54.0	500

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emissions from intentional radiators at a distance of 3 meters shall not exceed the above table.

Test Procedure

1. The EUT is placed on a turntable, which is 0.8m above ground plane.
2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
3. EUT is set 3m away from the receiving antenna, which is varied from 1m to 4m to find out the highest emissions.
4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
6. Repeat above procedures until the measurements for all frequencies are complete.

TEST RESULTS

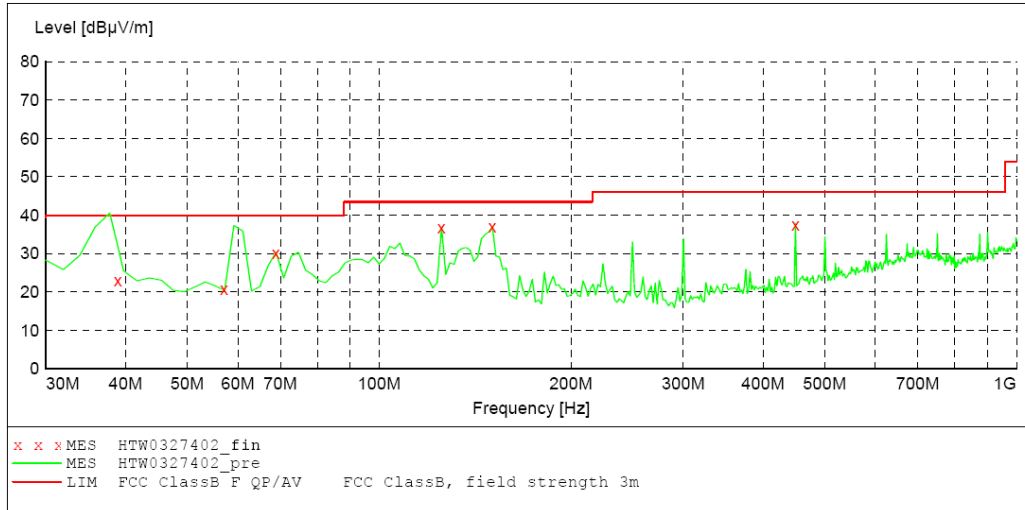
Operation Mode: Normal Operation

Temperature: 20 C Humidity: 70 % RH

Polarity: Ver. / Hor.

SCAN TABLE: "test Field(30M-1G)OP"

Short Description: Field Strength(30M-1G)
 Start Stop Step Detector Meas. IF Transducer
 Frequency Frequency Width Time Bandw.
 30.0 MHz 1.0 GHz 60.0 kHz QuasiPeak 1.0 s 120 kHz HL562 08



MEASUREMENT RESULT: "HTW0327402_fin"

3/27/2009 1:00PM

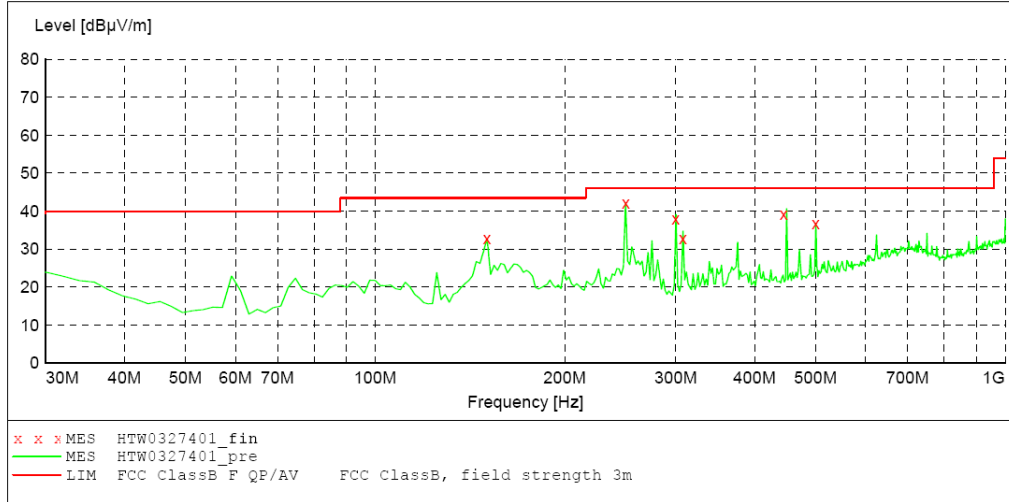
Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.	Height cm	Azimuth deg	Polarization
38.940000	23.00	15.8	40.0	17.0	QP	150.0	84.00	VERTICAL
57.120000	20.70	8.3	40.0	19.3	QP	127.0	318.00	VERTICAL
68.890000	30.00	10.4	40.0	10.0	QP	130.0	34.00	VERTICAL
125.250000	36.90	11.6	43.5	6.6	QP	116.0	255.00	VERTICAL
150.520000	37.00	10.8	43.5	6.5	QP	100.0	255.00	VERTICAL
449.890000	37.50	18.7	46.0	8.5	QP	145.0	59.00	VERTICAL

Remark:

- (1) Measuring frequencies from 30 MHz to the 1 GHz.
- (2) * denotes emission frequency which appearing within the Restricted Bands specified in provision of 15.205, then the general radiated emission limits in 15.209 apply.
- (3) Data of measurement within this frequency range shown "---" in the table above means the reading of emissions are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.
- (4) The IF bandwidth of EMI Test Receiver was 120KHz for measuring from 30 MHz to 1 GHz and 1 MHz for measuring above 1 GHz

SCAN TABLE: "test Field(30M-1G)OP"

Short Description: Field Strength(30M-1G)
 Start Stop Step Detector Meas. IF Transducer
 Frequency Frequency Width Time Bandw.
 30.0 MHz 1.0 GHz 60.0 kHz QuasiPeak 1.0 s 120 kHz HL562 08



MEASUREMENT RESULT: "HTW0327401_fin"

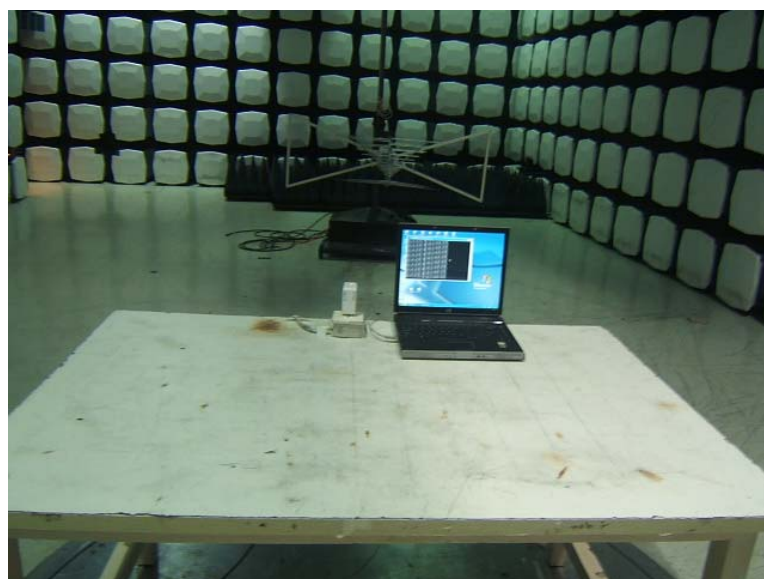
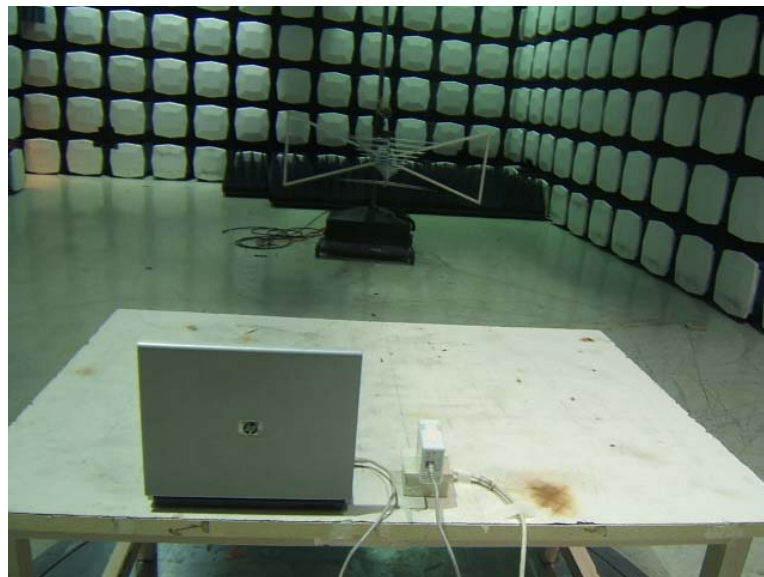
3/27/2009 1:20PM

Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.	Height cm	Azimuth deg	Polarization
150.520000	32.90	10.8	43.5	10.6	QP	305.0	255.00	HORIZONTAL
249.960000	42.10	12.4	46.0	3.9	QP	100.0	215.00	HORIZONTAL
300.000000	38.10	13.8	46.0	7.9	QP	120.0	79.00	HORIZONTAL
307.990000	32.80	14.1	46.0	13.2	QP	100.0	127.00	HORIZONTAL
445.000000	39.20	18.7	46.0	6.8	QP	100.0	224.00	HORIZONTAL
500.420000	36.80	20.1	46.0	9.2	QP	124.0	29.00	HORIZONTAL

Remark:

- (1) Measuring frequencies from 30 MHz to the 1 GHz.
- (2) * denotes emission frequency which appearing within the Restricted Bands specified in provision of 15.205, then the general radiated emission limits in 15.209 apply.
- (3) Data of measurement within this frequency range shown "---" in the table above means the reading of emissions are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.
- (4) The IF bandwidth of EMI Test Receiver was 120KHz for measuring from 30 MHz to 1 GHz and 1 MHz for measuring above 1 GHz

5. Test Setup Photos of the EUT



6. External and Internal Photos of the EUT

External Photos

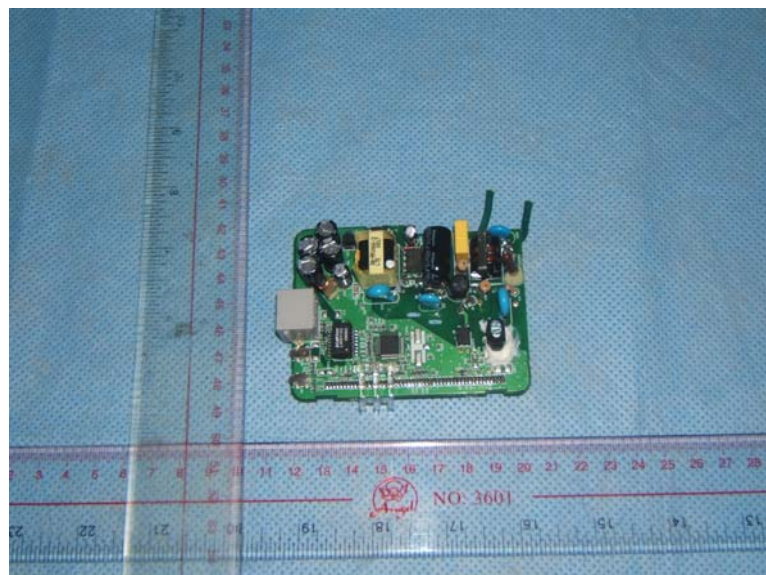


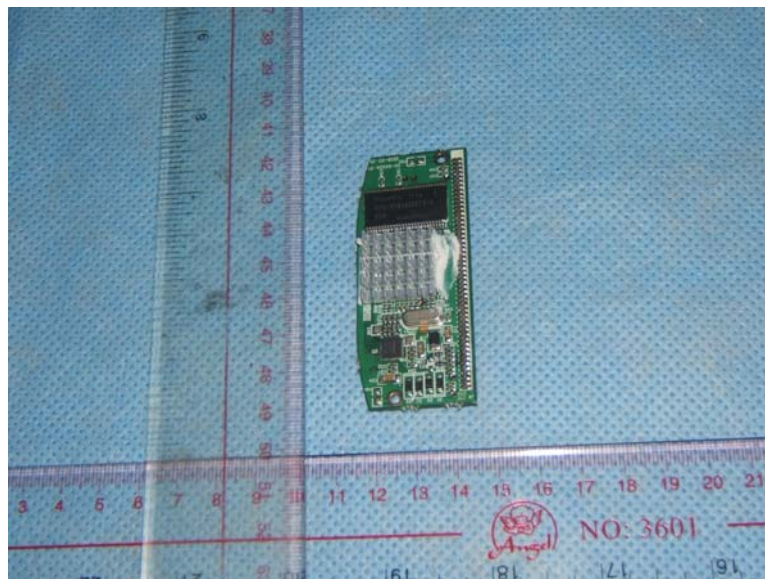
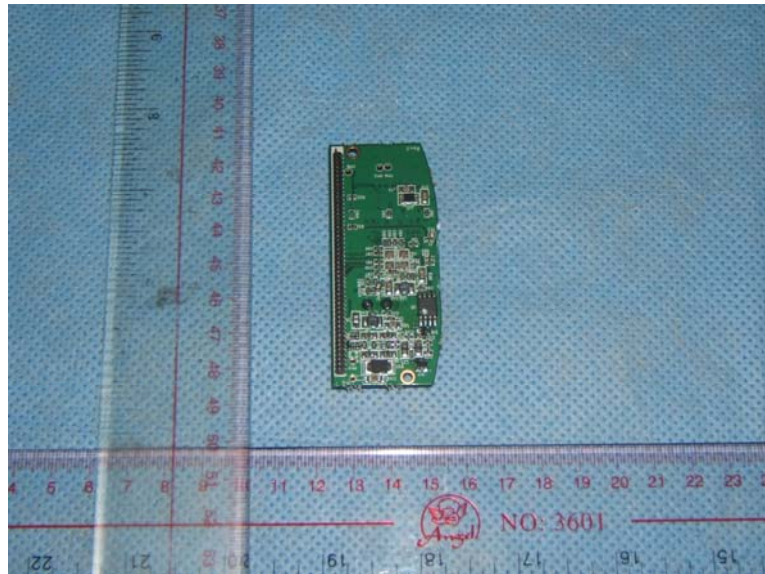


Internal Photos of the EUT

Internal Photos







.....End of Report.....